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RESISTORS, FIXED, WIREWOUND, ACCURATE,

BASED ON TYPE RBR 54

ESCC Detail Specification No. 4002/006

ISSUE 1 October 2002



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RESISTORS, FIXED, WIREWOUND, ACCURATE,

BASED ON TYPE RBR 54

ESA/SCC Detail Specification No. 4002/006



space components coordination group

| | | Approved by | | |
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DOCUMENTATION CHANGE NOTICE

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1. <u>GENERAL</u>

1.1 <u>SCOPE</u>

This specification details the ratings, physical and electrical characteristics, test and inspection data for Resistors, Fixed, Wirewound, Accurate, based on Type RBR 54. It shall be read in conjunction with ESA/SCC Generic Specification No. 4002, the requirements of which are supplemented herein.

1.2 RANGE OF COMPONENTS

The range of resistors covered by this specification is scheduled in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the resistors specified herein, are scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The applicable derating information for the resistors specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the resistors specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram for the resistors specified herein is shown in Figure 3.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

(a) ESA/SCC Generic Specification No. 4002, Resistors, Fixed, Wirewound.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used in this specification:

- R_A = Resistance value measured at ambient temperature (+22±3°C).
- Ri = Insulation Resistance.
- U_T = Test voltage.
- Uproof = d.c. or r.m.s. voltage proof.

U_{over L} = Overload voltage.



ISSUE 2

TABLE 1(a) - RANGE OF COMPONENTS

| Tolerance (%) | Resistance Range Rn (Ω) | Rated Dissipation Pn (mW) | Critical Resistance Rc (kΩ) |
|-----------------------------|----------------------------|------------------------------------|--------------------------------|
| ±0.01 | 100 to 3.0M | 250 | 357 |
| ±0.1 | 5.0 to 3.0M | 250 | 357 |
| ±0.25 | 5.0 to 3.0M | 250 | 357 |
| ±0.5 | 5.0 to 3.0M | 250 | 357 |
| ±1.0 | 5.0 to 3.0M | 250 | 357 |
| Temperature Coefficient TCR | | ±25 ppm/°C from ±5.0 ppm/°C abo | |

TABLE 1(b) - MAXIMUM RATINGS

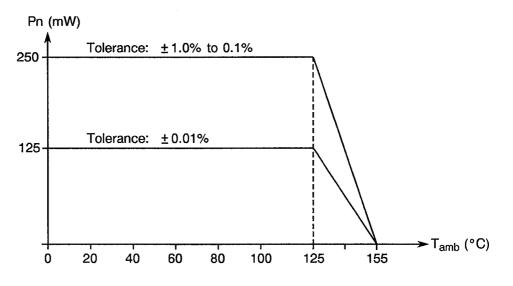
| No. | Characteristics | Symbol | Maximum Rating | Unit | Remarks |
|-----|--------------------------------|------------------|---------------------------------|------|--|
| 1 | Rated Dissipation | Pn | 250 | mW | At T _{amb} = +125°C |
| 2 | Limiting Element Voltage | UL | 300 | V | |
| 3 | Rated Voltage | U _R | -√PnRn (1) or U _L | V | Rn is the rated resistance |
| 4 | Operating Temperature Range | Т _{ор} | -55 to +155 | °C | T _{amb} |
| 5 | Soldering Temperature | T _{sol} | +245 | °C | Soldering Time ≤ 10s distance from body ≥ 1.5mm |

<u>NOTES</u>

1. Whichever is smaller.

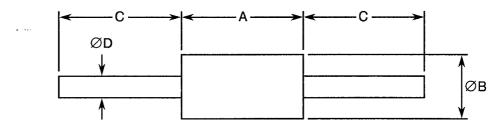


FIGURE 1 - PARAMETER DERATING INFORMATION



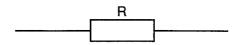
Power Dissipation versus Temperature

FIGURE 2 - PHYSICAL DIMENSIONS



| SYMBOL | MILLIMETRES | | |
|--------|-------------|-------|--|
| STWDUL | MIN. | MAX. | |
| A | 18.20 | 19.50 | |
| ØВ | 5.90 | 6.90 | |
| С | 35.00 | - | |
| ØD | 0.70 | 0.90 | |

FIGURE 3 - FUNCTIONAL DIAGRAM



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4. **REQUIREMENTS**

4.1 <u>GENERAL</u>

The complete requirements for procurement of the resistors specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 4002 for Resistors, Fixed, Wirewound. Deviations from the Generic Specification, applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not afect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

- 4.2.1 <u>Deviations from Special In-process Controls</u> None.
- 4.2.2 Deviations from Final Production Tests (Chart II)
 - (a) Para. 9.1, Overload: The conditions shall be as follows:
 Voltage: √2PnRn or 2U_L, whichever is less.
 Duration: 10 minutes.
- 4.2.3 <u>Deviations from Burn-in and Electrical Measurements (Chart III)</u> None.
- 4.2.4 <u>Deviations from Qualification Tests (Chart IV)</u> None.
- 4.2.5 <u>Deviations from Lot Acceptance Tests (Chart V)</u> None.
- 4.3 MECHANICAL REQUIREMENTS
- 4.3.1 Dimension Check

The dimensions of the resistors specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the resistors specified herein shall be 1.65 grammes.

4.3.3 Robustness of Terminations

The requirements for robustness of termination testing are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The test conditions shall be as follows:-

Test Ua1: TensileApplied Force: 10 Newtons.Duration: 5 to 10 seconds.



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4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the resistors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Enclosure or Protective Coating

Resistor assemblies shall be protected by a coating or enclosure of moisture-resistant insulating material which shall completely cover the outside of the resistor element, including connections of terminations. The coating shall not crack, craze, drip, run or form globules at any temperature up to and including +275°C, regardless of the mounting position of the resistor.

The protective coating or enclosure shall be such that it minimises the establishment of leakage paths between the terminals resulting from collection of moisture film on the outside surface of the resistor.

4.4.2 Lead Material and Finish

The lead material shall be Type 'A' with Type '3 or 4' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.4.3 Wire

Each resistor shall be wound with a conductor having no joints, welds or bands within each terminated resistance element.

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) The SCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

4.5.2 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:

| Detail Specification Number | <u>400200601B</u> |
|--|-------------------|
| Type Variant (see Note) | |
| Testing Level (B or C, as appropriate) | |

<u>N.B.</u>

Marking of the Type Variant number is mandatory. No further reference to type variants is made in this specification.



4.5.3 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Resistance Value.
- (b) Tolerance.
- (c) Temperature Coefficient.

The information shall be constituted and marked as follows:

4.5.3.1 Resistance Values

Resistance values shall be expressed by means of the following codes. The unit quantity for marking shall be Ohms (Ω).

| Resistance Value | Code |
|---------------------|-------|
| X.XXX | XRXXX |
| XX.XX | XXRXX |
| XXX.X | XXXRX |
| XXXX | XXXX0 |
| XXXX10 ¹ | XXXX1 |
| XXXX10 ² | XXXX2 |
| XXXX103 | XXXX3 |

For values of 1000 and above, the first 4 digits (X) represent significant figures and the last digit specifies the number of zeros to follow.

When values of less than 100 are required, the letter 'R' is used to indicate the decimal point. When the letter is used, all successive digits represent significant figures.

4.5.3.2 Tolerance

The tolerance on resistance values shall be indicated by the letter codes specified hereafter.

| Tolerance (±%) | Code Letter |
|----------------|-------------|
| 0.01 | L |
| 0.1 | В |
| 0.25 | С |
| 0.5 | D |
| 1.0 | F |

4.5.3.3 Temperature Coefficient

The temperature coefficient shall be indicated by the numerical codes specified hereafter.

| Digit | Temperature Coefficient (± ppm/°C) |
|-------|--|
| 1 | 5.0 |
| 2 | 25 |



4.5.4 <u>Traceability Information</u>

Traceability information shall be marked in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured on a sample basis at high and low temperatures are scheduled in Table 3. AQL shall be 0.65% out of the total production lot.

The distribution of the sample shall be as follows:

- 1/3 with the lowest resistance value,
- 1/3 with the highest resistance value,
- 1/3 with the median resistance value.

4.6.3 Circuits for Electrical Measurements (Figure 4)

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at $T_{amb} = +22 \pm 3$ °C. The parameter drift values (Δ) applicable to the parameters scheduled, shall not be exceeded. In addition to these drift value requirements, the appropriate limit value specified in Table 2 for a given parameter shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 4002. The conditions for burn-in shall be as specified in Table 5 of this specification.

The resistors shall be tested with a d.c. voltage with a ripple that shall not exceed 5.0%.

A voltage of 300V or \sqrt{PnRn} (see Figure 5) shall be applied in cycles of 90 minutes "on" and 30 minutes "off" throughout the test.

The resistors shall be connected by their terminations to suitable clips on a rack of insulating material. They shall be so arranged that the temperature of any one resistor does not appreciably influence the temperature of any other resistor. There shall be no undue draft over the resistors. After the period specified in the Generic Specification, the resistors shall be removed from the chamber and allowed to cool under normal atmospheric conditions for a minimum of 4 hours.

4.7.3 Electrical Circuits for Burn-in

The circuit for use in performing the burn-in test is shown in Figure 5 of this specification.



TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

| No. | Characteristics | Symbol | ESA/SCC 4002 Test Method | Test Conditions | Tolerance | Lin | | |
|-----|-----------------------|--------------------|-----------------------------|-----------------------------|-----------|-----------|-----------|------|
| | | | | | (±%) | Min. | Max. | Unit |
| 1 | Resistance | R _A | Para. 9.5.1.1 | Para. 9.5.1.1 | 0.01 | 0.9999 Rn | 1.0001 Rn | Ω |
| | | | | | 0.1 | 0.9990 Rn | 1.0010 Rn | |
| | | | | | 0.25 | 0.9975 Rn | 1.0025 Rn | |
| | | | | | 0.5 | 0.995 Rn | 1.005 Rn | |
| | | | | | 1.0 | 0.990 Rn | 1.010 Rn | |
| 2 | Insulation Resistance | Ri | Para. 9.5.1.2 | Para. 9.5.1.2.1 (Note 1) | All | 1 000 | - | MΩ |
| 3 | Voltage Proof | U _{proof} | Para. 9.5.1.3 | Para. 9.5.1.3.1 | All | 750 | - | Vrms |

NOTES

1. Measurements shall be performed on a sample basis; sample size as specified in Para. 4.6.2, Level II, AQL = 0.65%.

TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

| No. | Characteristics | Symbol | ESA/SCC 4002 | Test Conditions | Resistance | Lin | Unit | |
|------|--|----------------|---------------|--------------------|------------------|------------------|------------------|---|
| | Undractenstics | Symbol | Test Method | (Note 1) | Range | Min. | Max. | |
| 1(a) | Resistance Change between -55(+3-0)°C and +22±3°C | <u>∆R</u> R | Para. 9.5.1.1 | Para. 9.5.1.1 | Rn≤100 Rn>100 | -0.2 -0.04 | +0.2 +0.04 | % |
| 1(b) | Resistance Change between +155(+0-3)°C and +22±3°C | <u>∆R</u> R | Para. 9.5.1.1 | Para. 9.5.1.1 | Rn≤100 Rn>100 | - 0.35 - 0.07 | + 0.35 + 0.07 | % |

NOTES

1. Sample size as specified in Para. 4.6.2: Level II, AQL = 0.65%.

FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.



TABLE 4 - PARAMETER DRIFT VALUES

| Characteristics | Symbol | Spec. and/or Test Method | Test Conditions | Change Limits (Δ) | Unit |
|-------------------|-------------------------|-----------------------------|-----------------|--------------------------|--------|
| Resistance Change | $rac{\Delta R_A}{R_A}$ | As per Table 2 | As per Table 2 | ±0.01 or (1) ±0.02 | Ω % |

NOTES

1. Whichever is greater.

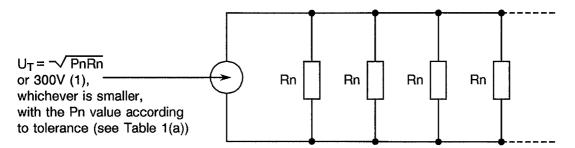
| TABLE 5 - CONDITIONS | COD DUDN IN | AND ODEDATING | LIEE TEOTO |
|-----------------------------|-------------|---------------|------------|
| TABLE 5 - CONDITIONS | | AND OPERATING | LIFE IESIS |

| No. | Characteristics | Symbol | Condition | Unit |
|-----|---|------------------|--|------|
| 1 | Ambient Temperature for Initial Measurement | T _{amb} | +22±3 | °C |
| 2 | Temperature for Burn-in and Operating Life Tests | T _{amb} | + 125 ± 3 | °C |
| 3 | Voltage Applied | UT | \sqrt{PnRn} , or 300V, whichever is less (1) | V |
| 4 | Temperature for Final Measurement | T _{amb} | + 22 ± 3 | °C |

NOTES

1. For tolerance better than 0.1%, use Figure 1 derating curve for burn-in only.

FIGURE 5 - CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS



NOTES

1. For 0.01% tolerance, use the Figure 1 derating curve.



4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC</u> SPECIFICATION NO. 4002)

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6 of this specification. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22±3 °C.

4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance testing are scheduled in Table 6 of this specification. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ± 3 °C.

4.8.4 <u>Conditions for Operating Life Tests (Part of Endurance Testing)</u>

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The conditions for operating life testing shall be as specified in Table 5 and Para. 4.7.2 of this specification.

4.8.5 <u>Electrical Circuits for Operating Life Tests</u>

The circuit for use in performing the operating life tests is shown in Figure 5 of this specification.

4.8.6 Conditions for High Temperature Storage Test (Part of Endurance Testing)

The requirements for the high temperature storage test are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The conditions for high temperature storage shall be $T_{amb} = +155(+0-5)$ °C.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

| | ESA/SCC GENERIC | SPEC. No. 4002 | MEASUREMENTS AN | ID INSPECTIONS | | LIM | ITS | |
|-----|--|---|---|--|--|--------------------------|------------------------------|--------|
| NO. | ENVIRONMENTAL AND ENDURANCE TESTS (1) | TEST METHOD AND CONDITIONS | IDENTIFICATION | CONDITIONS | SYMBOL | MIN. | MAX. | UNIT |
| 01 | Overload | Para. 9.1 and Para. 4.2.2 of this specification | Initial Measurements Resistance Final Measurements | Table 2 Item 1 After 1 to 2 hrs recovery | R _A | Table 2 | Item 1 | |
| | | | Visual Examination Resistance Change | No damage Legible marking Table 2 Item 1 | - ΔR _A /R _A | - ± (0.25 + <u>(</u> | - <u>).05</u> ×100) Rn | - % |
| 02 | Permanence of Marking | Para. 9.6 | Final Measurements Visual Examination | No corrosion or obliteration of marking | - | - | - | - |
| 03 | Temperature Characteristic of Resistance | Para. 9.7 Procedure II | During Test Temperature Characteristic of Resistance | Para. 9.7.3 of ESA/SCC No. 4002 | TCR | Table | e 1(a) | ppm/°C |
| 04 | Voltage Proof (Altitude) | Para. 9.8 | During Test Visual Examination | 200Vrms for 5 seconds No breakdown or flashover | - | - | - | - |
| 05 | Solderability | Para. 9.9 Procedure II | Final Measurements Visual Examination | No damage Legible marking | - | I | - | - |
| 06 | Robustness of Terminations | Para 9.10 and Para. 4.3.3 of this specification | Initial Measurements Resistance Final Measurements Visual Examination Resistance Change | Table 2 Item 1 No damage Table 2 Item 1 | R _A - ΔR _A /R _A | Table 2 - ± (0.019 | tem 1 - % +0.1Ω) | - Ω |
| 07 | Resistance to Soldering Heat | Para. 9.11 Procedure I | Initial Measurements Resistance Final Measurements | Table 2 Item 1 After 24 ± 4 hours recovery | R _A | Table 2 | | |
| | | | Visual Examination Resistance Change | No damage Legible marking Table 2 Item 1 | - ΔR _A /R _A | - ± (0.01 | - % + 0.1Ω) | Ω |
| 08 | Rapid Change of Temperature | Para. 9.12 and Table 1(b) of this spec. | Initial Measurements Resistance Final Measurements | Table 2 Item 1 After 1 to 2 hrs recovery | R _A | Table 2 | 2 Item 1 | |
| | | | Visual Examination Resistance Change | No damage Table 2 Item 1 | $\Delta R_A/R_A$ | - ± (0.05% | - 5 + 0.0 1Ω) | - Ω |
| 09 | Vibration | Para. 9.13 | Initial Measurements Resistance Final Measurements | Table 2 Item 1 | R _A | Table 2 | 2 Item 1 | |
| | | | Visual Examination Resistance Change | No damage Table 2 Item 1 | - ∆R _A /R _A | - ± (0.01% | +0.01Ω) | - Ω |

NOTES

1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

| | ESA/SCC GENERIC | SPEC. NO. 4002 | MEASUREMENTS AN | | LIMITS | | | |
|-----|---|-------------------------------|--|---|---------------------------------------|------------------|--------------------|---------|
| NO. | ENVIRONMENTAL AND ENDURANCE TESTS (1) | TEST METHOD AND CONDITIONS | IDENTIFICATION | CONDITIONS | SYMBOL | MIN. | MAX. | UNIT |
| 10 | Climatic Sequence | Para. 9.14 Procedure I | Initial Measurements Resistance Final Measurements | After Drying Table 2 Item 1 After 1 to 2 hrs recovery | R _A | Table 2 | Item 1 | |
| | | | Visual Examination Resistance Change Insulation Resistance | No damage Legible marking Table 2 Item 1 Table 2 Item 2 | ∆R _A /R _A Ri | ± (0.01% 1000 | +0.01Ω) - | Ω ΜΩ |
| 11 | Operating Life | Para. 9.15 Chart IV | Initial Measurements Resistance Intermediate Measurements | Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs | R _A | Table 2 | ltem 1 | |
| | | | Resistance Change Final Measurements | recovery Table 2 Item 1 2000 ± 48 hrs After 1 to 2 hrs recovery | $\Delta R_A/R_A$ | ± (0.07% | +0.01Ω) | Ω |
| | | | Resistance Change Visual Examination | Table 2 Item 1 No damage | ΔR _A /R _A - | ± (0.1% - | +0.01Ω) - | Ω - |
| | | Para. 9.15 Chart V | Initial Measurements Resistance Final Measurements | Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs | R _A | Table 2 | ltem 1 | |
| | | | Resistance Change Visual Examination | recovery Table 2 Item 1 No damage | ∆R _A /R _A | ± (0.07% - | +0.01Ω) - | Ω - |
| 12 | High Temperature Storage | Para. 9.16 | Initial Measurements Resistance Intermediate Measurements | Table 2 Item 1 1000 ± 48 hrs | R _A | Table 2 | Item 1 | |
| | | | Resistance Change Final Measurements Resistance Change | Table 2 Item 1 2000 ± 48 hrs Table 2 Item 1 | $\Delta R_A/R_A$ $\Delta R_A/R_A$ | | +0.01Ω) +0.01Ω) | Ω Ω |
| 13 | External Visual Inspection | Para. 9.17 | Visual Inspection | ESA/SCC No. 20500 | - | - | - | - |
| 14 | Maximum Time Constant (Not applicable to inductive resistors) | Para. 9.18 | Time Constant | Para. 9.18.1 of ESA/SCC No. 4002 | L/R | Table | • 1(b) | ns |

NOTES: See Page 15.